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| Substitute Form PTO-1449<br>(Modified)  | U.S. Department of Commerce<br>Patent and Trademark Office | Attorney's Docket No.<br>12406-147US1 | Application No.<br>10/567,883 |
| <b>Information Disclosure Statement<br/>by Applicant</b><br>(Use several sheets if necessary) |  | Applicant<br>Wilhelm Stein et al.     |                               |
|   |  | Filing Date<br>August 14, 2006        | Group Art Unit<br>2826        |
| (37 CFR §1.98(b))   |  |                                       |                               |

**U.S. Patent Documents**

| Examiner Initial | Desig. ID | Document Number | Publication Date | Patentee | Class | Subclass | Filing Date If Appropriate |
|------------------|-----------|-----------------|------------------|----------|-------|----------|----------------------------|
|                  | AA        |                 |                  |          |       |          |                            |
|                  | AB        |                 |                  |          |       |          |                            |
|                  | AC        |                 |                  |          |       |          |                            |
|                  | AD        |                 |                  |          |       |          |                            |
|                  | AE        |                 |                  |          |       |          |                            |
|                  | AF        |                 |                  |          |       |          |                            |
|                  | AG        |                 |                  |          |       |          |                            |
|                  | AH        |                 |                  |          |       |          |                            |
|                  | AI        |                 |                  |          |       |          |                            |
|                  | AJ        |                 |                  |          |       |          |                            |
|                  | AK        |                 |                  |          |       |          |                            |

**Foreign Patent Documents or Published Foreign Patent Applications**

| Examiner Initial | Desig. ID | Document Number | Publication Date | Country or Patent Office | Class | Subclass | Translation |    |
|------------------|-----------|-----------------|------------------|--------------------------|-------|----------|-------------|----|
|                  |           |                 |                  |                          |       |          | Yes         | No |
| /FYL/            | AL        | WO 01/41223     | 6/7/2001         | WIPO                     | H01L  | 33/00    |             |    |
|                  | AM        |                 |                  |                          |       |          |             |    |
|                  | AN        |                 |                  |                          |       |          |             |    |
|                  | AO        |                 |                  |                          |       |          |             |    |
|                  | AP        |                 |                  |                          |       |          |             |    |

**Other Documents (include Author, Title, Date, and Place of Publication)**

| Examiner Initial | Desig. ID | Document |
|------------------|-----------|----------|
|                  | AQ        |          |
|                  | AR        |          |
|                  | AS        |          |
|                  | AT        |          |

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| Examiner Signature<br>Feifei Yeung Lopez/ (08/14/2008)   | Date Considered |
| EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. |                 |